MOSFET - N-Channel Shielded Gate PowerTrench® 150 V, 10.9 mΩ, 75.4 A

NTB011N15MC

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 10.9 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 41 \text{ A}$
- 50% Lower Qrr than other MOSFET Suppliers
- Lowers Switching Noise/EMI
- 100% UIL Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	150	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current R _{θJC} (Note 2)	Steady T 0500		I _D	75.4	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	State	T _C = 25°C	P _D	136.4	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State	T _A = 25°C	Ι _D	12.5	Α
Power Dissipation R _{θJA} (Notes 1, 2)		,,	P _D	3.75	W
Pulsed Drain Current	$T_C = 25^{\circ}C, t_p = 100 \ \mu s$		I _{DM}	323	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy (I _L = 14 A _{pk} , L = 3 mH)			E _{AS}	294	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

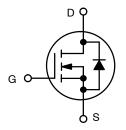
- 1. Surface-mounted on FR4 board using a 1 in2, 2 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



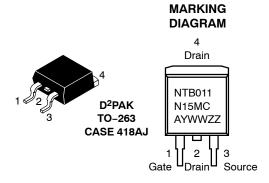
ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	10.9 m Ω @ 10 V	75.4 A



N-CHANNEL MOSFET



NTB011N15MC = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTB011N15MC	D ² PAK (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	1.1	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	40	

Parameter	Symbol	Test Condit	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		150			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			83		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 120 V	T _J = 25°C			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 223 μA	2.5		4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 223 μA, ref	to 25°C		-8.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 41 \text{ A}$ $V_{GS} = 8 \text{ V}, I_D = 20 \text{ A}$			8.7	10.9	mΩ
					9.3	12.6	
Forward Transconductance	9FS	V _{DS} = 10 V, I _D	= 41 A		85		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C _{ISS}				2810		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz	z, V _{DS} = 75 V		840		pF
Reverse Transfer Capacitance	C _{RSS}				14		
Gate-Resistance	R_{G}				0.8	1.6	Ω
Total Gate Charge	Q _{G(TOT)}				37		
Threshold Gate Charge	Q _{G(TH)}				9.1		
Gate-to-Source Charge	Q_{GS}	V _{GS} = 10 V, V _{DS} = 75 V; I _D = 41 A			15		nC
Gate-to-Drain Charge	Q_{GD}				6.5		1
Plateau Voltage	V_{GP}				5.4		V
Output Charge	Q _{OSS}	V _{DD} = 75 V, V _{GS} = 0 V			95		nC
SWITCHING CHARACTERISTICS (Note 3)							
Turn-On Delay Time	t _{d(ON)}				19		
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	₀ = 75 V,		14]
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 41 \text{ A}, R_G = 4.7 \Omega$			28		- ns
Fall Time	t _f				5.1		
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 41 A	T _J = 25°C		0.92	1.2	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD}	= 75 V		49		ns
Reverse Recovery Charge	Q_{RR}	$dI_S/dt = 300 \text{ A/}\mu\text{s}, I_S = 41 \text{ A}$			210		nC
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } V_{DD} = 75 \text{ V}$ $dI_S/dt = 1000 \text{ A/}\mu\text{s, } I_S = 41 \text{ A}$			36		ns
Reverse Recovery Charge	Q _{RR}				421		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

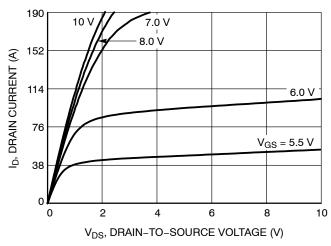


Figure 1. On-Region Characteristics

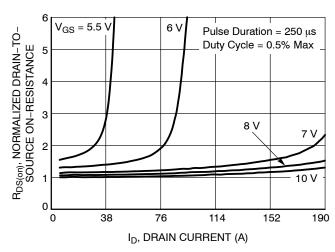


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

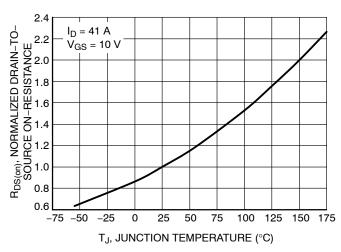


Figure 3. Normalized On–Resistance vs. Junction Temperature

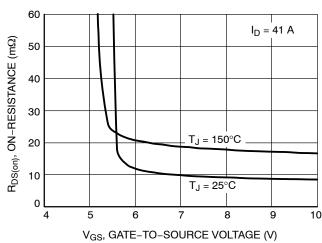


Figure 4. On-Resistance vs. Gate-to-Source Voltage

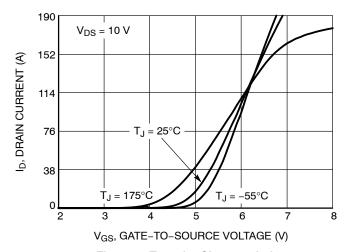


Figure 5. Transfer Characteristics

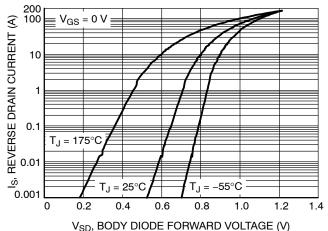


Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS

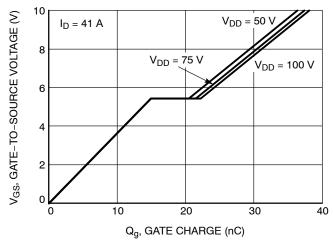


Figure 7. Gate Charge Characteristics

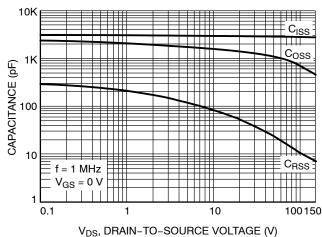


Figure 8. Capacitance vs. Drain-to-Source
Voltage

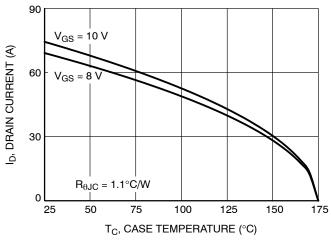


Figure 9. Drain Current vs. Case Temperature

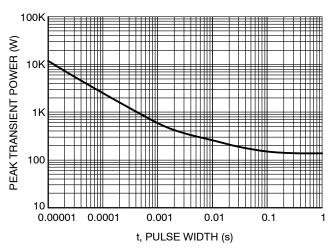


Figure 10. Peak Power

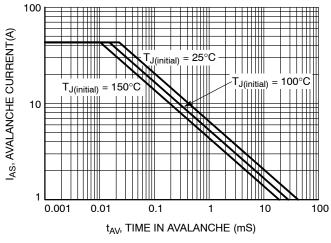


Figure 11. Unclamped Inductive Switching Capability

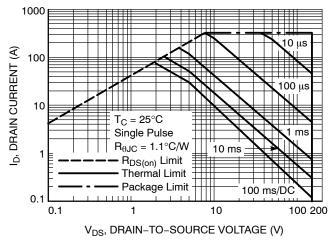


Figure 12. Forward Bias Safe Operating Area

TYPICAL CHARACTERISTICS

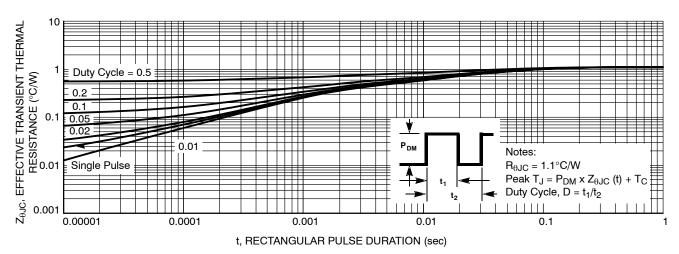


Figure 13. Transient Thermal Impedance

PACKAGE DIMENSIONS

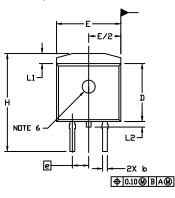
D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ

ISSUE E

NUTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- CHAMFER OPTIONAL.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIN	ETERS	
DIM	MIN.	MAX.	MIN.	MAX.	
Α	0.160	0.190	4.06	4.83	
A1	0.000	0.010	0.00	0.25	
b	0.020	0.039	0.51	0.99	
c	0.012	0.029	0.30	0.74	
c2	0.045	0.065	1.14	1.65	
D	0.330	0.380	8.38	9.65	
D1	0.260		6.60		
Ε	0.380	0.420	9.65	10.67	
E1	0.245		6.22		
e	0.100 BSC		2.54	2.54 BSC	
Н	0.575	0.625	14.60	15.88	
L	0.070	0.110	1.78	2.79	
L1		0.066		1.68	
L2		0.070		1.78	
L3	0.010 BSC		0.25	.25 BSC	
М	-8*	8*	-8*	8*	



RECOMMENDED MOUNTING FOOTPRINT

0.436

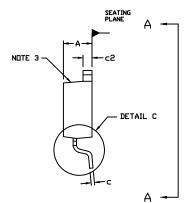
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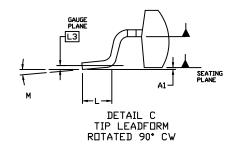
2x 0.063

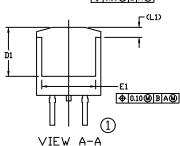
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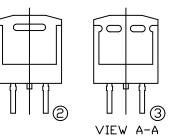
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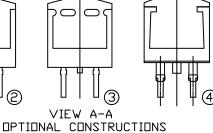
0.100 PITCH











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